

# PNZ313B

## PIN Photodiode

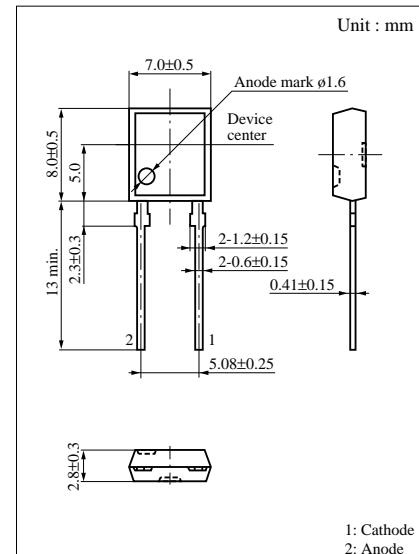
For optical control systems

### ■ Features

- Fast response which is well suited to high speed modulated light detection :  $t_r, t_f = 50$  ns (typ.)
- High sensitivity, high reliability
- Peak sensitivity wavelength matched with infrared light emitting diodes :  $\lambda_p = 960$  nm (typ.)
- Wide detection area, wide acceptance half angle :  $\theta = 65$  deg. (typ.)
- Adoption of visible light cutoff resin

### ■ Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Ratings	Unit
Reverse voltage (DC)	$V_R$	30	V
Power dissipation	$P_D$	100	mW
Operating ambient temperature	$T_{opr}$	-30 to +85	°C
Storage temperature	$T_{stg}$	-40 to +100	°C

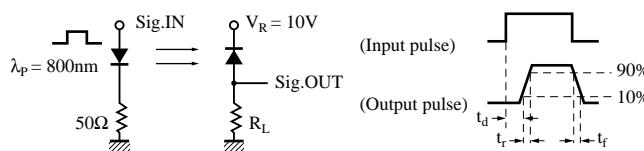


### ■ Electro-Optical Characteristics ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Conditions	min	typ	max	Unit
Dark current	$I_D$	$V_R = 10\text{V}$		5	50	nA
Photo current	$I_L$	$V_R = 10\text{V}, L = 1000 \text{ lx}^{*1}$	15	25		µA
Peak sensitivity wavelength	$\lambda_p$	$V_R = 10\text{V}$		960		nm
Response time	$t_r, t_f^{*2}$	$V_R = 10\text{V}, R_L = 1\text{k}\Omega$		50		ns
Response time	$t_r, t_f^{*2}$	$V_R = 10\text{V}, R_L = 100\text{k}\Omega$		5		µs
Capacitance between pins	$C_t$	$V_R = 0\text{V}, f = 1\text{MHz}$	70			pF
Acceptance half angle	$\theta$	Measured from the optical axis to the half power point		65		deg.

\*1 Measurements were made using a tungsten lamp (color temperature  $T = 2856\text{K}$ ) as a light source.

\*2 Switching time measurement circuit



$t_d$  : Delay time  
 $t_r$  : Rise time (Time required for the collector photo current to increase from 10% to 90% of its final value)  
 $t_f$  : Fall time (Time required for the collector photo current to decrease from 90% to 10% of its initial value)

